



TEST REPORT

Reference No.	-24	WTF24F03057624W001		
Applicant	int	Mid Ocean Brands B.V.		
Address		7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong		
Manufacturer	:	114746		
Address	1	and a set of the set o		
Product Name	:	Wireless bamboo speaker		
Model No	sal	MO6385		
Test specification	10	ETSI EN 300 328 V2.2.2 (2019-07)		
Date of Receipt sample		2024-03-21		
Date of Test	S.	2024-03-23		
Date of Issue	÷	2024-04-08		
Test Report Form No	-5	WEW-300328A-01B		
Test Result	:	Pass the second se		

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

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fong

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1 Test Summary

Radio Spectrum						
Test	Test Requirement	Limit / Severity	Result			
RF output power	ETSI EN 300 328 V2.2.2	≤20dBm	Pass			
Duty Cycle, Tx-sequence, Tx-gap	ETSI EN 300 328 V2.2.2	15 15 10 5th	N/A			
Accumulated Transmit Time, Frequency Occupation and Hopping Sequence	ETSI EN 300 328 V2.2.2	Clause 4.3.1.4.3	Pass			
Hopping Frequency Separation	ETSI EN 300 328 V2.2.2	≥100kHz	Pass			
Medium Utilization	ETSI EN 300 328 V2.2.2	whet must where whe	N/A			
Adaptivity (Adaptive Frequency Hopping)	ETSI EN 300 328 V2.2.2	a 10 50 50	N/A			
Occupied Channel Bandwidth	ETSI EN 300 328 V2.2.2	Within the band 2400- 2483.5MHz	Pass			
Transmitter unwanted in the OOB domain	ETSI EN 300 328 V2.2.2	Figure 1	Pass			
Transmitter unwanted emissions in the spurious domain	ETSI EN 300 328 V2.2.2	Table 4	Pass			
Receiver spurious emissions	ETSI EN 300 328 V2.2.2	Table 5	Pass			
Receiver Blocking	ETSI EN 300 328 V2.2.2	Clause 4.3.1.12.4	Pass			

Remark:

Pass Test item meets the requirement

N/A Not Applicable



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3 General Information

3.1 General Description of E.U.T.

Product Name :	Wireless bamboo speaker
Model No:	MO6385
Remark:	The she was a she was
Rating	Input: DC 5V, 0.3A Battery: 3.7V, 300mAh, 1.11Wh
Battery Capacity	
Adapter Model	Netter which when a

3.2 Technical Specification

- M . N . N . N .		
Bluetooth Version	:	Bluetooth V5.3 (BR+EDR)
Frequency Range	÷	2402-2480MHz
Maximum RF Output Power	:	-0.99 dBm (EIRP)
Type of Modulation	Ξ,	GFSK, π/4QPSK, 8DPSK
Data Rate	:	1Mbps, 2Mbps, 3Mbps
Quantity of Channels	j,Š	79
Channel Separation	:	1MHz
Antenna installation	:	PCB Antenna
Antenna Gain	A	1dBi
Receiver Category	:	3

Receiver Category	Description
1	Adaptive equipment with a maximum RF output power greater than 10 dBm e.i.r.p.
2	non-adaptive equipment with a Medium Utilization (MU) factor greater than 1 % and less than or equal to 10 % (irrespective of the maximum RF output power); or equipment (adaptive or non-adaptive) with a maximum RF output power greater than 0 dBm e.i.r.p. and less than or equal to 10 dBm e.i.r.p.
3 ANT - 3 ANT - 4	non-adaptive equipment with a maximum Medium Utilization (MU) factor of 1 % (irrespective of the maximum RF output power) or equipment (adaptive or non-adaptive) with a maximum RF output power of 0 dBm e.i.r.p.

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3.3 Standards Applicable for Testing

The tests were performed according to following standards:

ETSI EN 300 328 V2.2.2 (2019-07)

Electromagnetic compatibility and Radio spectrum Matters (ERM); Wideband transmission systems; Data transmission equipment operating in the 2,4 GHz ISM band and using wide band modulation techniques; Harmonized EN covering essential requirements under article 3.2 of the RED Directive.

3.4 Test Facility

The test facility has a test site registered with the following organizations:

• ISED – Registration No.: 21895

Waltek Testing Group (Foshan) Co., Ltd. has been registered and fully described in a report filed with the Innovation, Science an Economic Development Canada(ISED). The acceptance letter from the ISED is maintained in our files. Registration ISED number:21895, March 12, 2019

• FCC – Registration No.: 820106

Waltek Testing Group (Foshan) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 820106, August 16, 2018

• NVLAP – Lab Code: 600191-0

Waltek Testing Group (Foshan) Co., Ltd. EMC Laboratory is accredited by the National Voluntary Laboratory Accreditation Program (NVLAP/NIST). NVLAP Code: 600191-0.

This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

3.5 Subcontracted

Whether parts of tests for the product have been subcontracted to other labs:

🗌 Yes 🛛 🖾 No

If Yes, list the related test items and lab information:

Test items:---

Lab information:---

3.6 Abnormalities from Standard Conditions

None.

3.7 Disclaimer

The antenna gain information is provided by the customer. The laboratory is not responsible for the accuracy of the antenna gain information.



4 Equipment Used during Test

4.1 Equipment List

ltem	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1	3m Semi-anechoic Chamber	CHANGCHUANG	9m×6m×6m	and the start of	2024-01-05	2025-01-04
2	EMI TEST RECEIVER	RS	ESR7	101566	2024-01-06	2025-01-05
3	Spectrum Analyzer	Agilent	N9020A	MY48011796	2024-01-04	2025-01-03
4	Trilog Broadband Antenna	SCHWARZBECK	VULB9162	9162-117	2024-01-05	2025-01-04
5	Coaxial Cable (below 1GHz)	H+S	CBL3-NN- 12+3 m	214NN320	2024-01-06	2025-01-05
6	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9120 D	01561	2024-01-05	2025-01-04
7	Broadband Preamplifier (Above 1GHz)	Lunar E M	LNA1G18-40	20160501002	2024-01-04	2025-01-03
8	Coaxial Cable (above 1GHz)	Times-Micorwave	CBL5-NN	m m	2024-01-04	2025-01-03
⊠RF	Conducted test	the state	50 .50	MUTER MUTER	and and	m. n
ltem	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1	Environmental Chamber	KSON	THS-D4C-100	5244K	2024-01-17	2025-01-16
2	Spectrum Analyzer	Agilent	N9020A	MY48011796	2024-01-04	2025-01-03
3	EXG Analog Signal Generator	Agilent	N5181A	MY48180720	2024-01-04	2025-01-03
4	RF Control Unit	CHANGCHUANG	JS0806-2	\$ - S	2024-01-04	2025-01-03
5	Wideband radio communication tester	Rohde&Schwarz	CMW500	1201.0002K50 -158178-Qf	2024-01-04	2025-01-03
6	USB Wideband Power Sensor	KEYSIGHT	U2021XA	MY56510008	2024-01-04	2025-01-03

: Not Used

🛛: Used

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4.2 Software List

Description	Manufacturer	Model	Version
EMI Test Software (Radiated Emission)	FARATRONIC	EZ-EMC	RA-03A1-1
RF Conducted Test	TONSCEND	JS1120-2	2.6

4.3 Special Accessories and Auxiliary Equipment

Item	Equipment	Technical Data	Manufacturer	Model No.	Serial No.
1.	and the lands a	e ar ar	1	1.50	and mathematic

4.4 Measurement Uncertainty

Parameter	Uncertainty	Note	
RF Output Power	±2.2dB	(1)	
Occupied Bandwidth	±1.5%	(1)	
	±3.8dB (for 25MHz-1GHz)	(1)	
Transmitter Spurious Emission	±5.0dB (for 1GHz-18GHz)	(1)	

(1)This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

4.5 Decision Rule

Compliance or non-compliance with a disturbance limit shall be determined in the following manner.

If U_{LAB} is less than or equal to U_{cispr} , then

-Compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;

-Non-compliance is deemed to occur is any measured disturbance level exceeds the disturbance limt.

If U_{LAB} is greater than U_{cispr} , then

-Compliance is deemed to occur if no measured disturbance level, increased by $(U_{LAB}-U_{cispr})$, exceeds the disturbance limit;

-Non-compliance is deemed to occur if any measured disturbance level, increased by $(U_{LAB}-U_{cispr})$, exceeds the disturbance limit.



5 Test Conditions and Test mode

The equipment under test (EUT) was configured to measure its highest possible emission/immunity level. The test modes were adapted according to the operation manual for use, the EUT was operated in the continuous transmitting mode that was for the purpose of the measurements, more detailed description as follows:

Test Mode List				
Test Mode	Description	Remark		
TM1	Low	2402MHz		
TM2	Middle	2441MHz		
TM3	High	2480MHz		
TM4	Hopping	2402-2480MHz		

Modulation Configure				
Modulation	Packet			
WILL MALE MALE MALE SALE	DH1			
GFSK	DH3			
	DH5 MM MM			
at the second second	2DH1			
π/4QPSK	2DH3			
t mart martine survive survive survive all	2DH5			
at at not the state state and	3DH1			
8DPSK	3DH3			
and the same same share a second second a	3DH5			

Test Conditions									
LAD B	Normal	LTNV	HTNV						
Temperature (°C)	22	-10	+50						
Voltage (Vdc)	Martin Martin Sular	3.7	1 1 1						
Relative Humidity:	at and with	45 %	m. m.						
ATM Pressure:	a a a	101.2kPa	1 5						



6 **RF Requirements**

6.1 RF Output power

6.1.1 Standard Applicable

According to Section 4.3.1.2.3, The RF output power for FHSS equipment shall be equal to or less than 20 dBm.

For non-adaptive FHSS equipment, where the manufacturer has declared an RF output power lower than 20 dBm e.i.r.p., the RF output power shall be equal to or less than that declared value.

This limit shall apply for any combination of power level and intended antenna assembly.

The measurements for RF output power shall be performed at both normal environmental conditions and at the extremes of the operating temperature range.

6.1.2 Test Procedure

According to section 5.4.2.2.1.2 of the standard ETSI EN 300328, the test procedure shall be as follows: **Step 1:**

• Use a fast power sensor suitable for 2,4 GHz and capable of 1 MS/s.

• Use the following settings: - Sample speed 1 MS/s or faster.

- The samples must represent the power of the signal.

- Measurement duration: For non-adaptive equipment: equal to the observation period defined in clauses 4.3.1.2.1

or 4.3.2.3.1. For adaptive equipment, the measurement duration shall be long enough to ensure a minimum number of bursts (at least 10) are captured.

NOTE 1: For adaptive equipment, to increase the measurement accuracy, a higher number of bursts may be used.

Step 2:

• For conducted measurements on devices with one transmit chain:

- Connect the power sensor to the transmit port, sample the transmit signal and store the raw data.Use these stored samples in all following steps.

• For conducted measurements on devices with multiple transmit chains:

- Connect one power sensor to each transmit port for a synchronous measurement on all transmit ports.

- Trigger the power sensors so that they start sampling at the same time. Make sure the time difference between

the samples of all sensors is less than half the time between two samples.

- For each individual sampling point (time domain), sum the coincident power samples of all ports and store them.

Use these summed samples in all following steps..



Step 3:

• Find the start and stop times of each burst in the stored measurement samples.

The start and stop times are defined as the points where the power is at least 30 dB below the highest value of the stored samples in step 2.

NOTE 2: In case of insufficient dynamic range, the value of 30 dB may need to be reduced appropriately.

Step 4:

• Between the start and stop times of each individual burst calculate the RMS power over the burst using the formula below. Save these Pburst values, as well as the start and stop times for each burst.

$$P_{burst} = \frac{1}{k} \sum_{n=1}^{k} P_{sample}(n)$$

with 'k' being the total number of samples and 'n' the actual sample number

Step 5:

• The highest of all Pburst values (value "A" in dBm) will be used for maximum e.i.r.p. calculations.

Step 6:

• Add the (stated) antenna assembly gain "G" in dBi of the individual antenna.

• If applicable, add the additional beamforming gain "Y" in dB.

•If more than one antenna assembly is intended for this power setting, the maximum overall antenna gain (G or G

+ Y) shall be used.

• The RF Output Power (P) shall be calculated using the formula below: P = A + G + Y

• This value, which shall comply with the limit given in clause 4.3.1.2.3 or clause 4.3.2.2.3, shall be recorded in the test report.



6.1.3 Test Result

Modulation Type	Test Condition	Test Mode	Channel	EIRP (dBm)	Limit (dBm)	Verdict
	TLVN	DH5	Нор	-4.63	20	Pass
GFSK	TNVN	DH5	Нор	-3.66	20	Pass
	THVN	DH5	Нор	-3.6	20	Pass
t	TLVN	2DH5	Нор	-2.86	20	Pass
π/4QPSK	TNVN	2DH5	Нор	-2.88	20	Pass
	THVN	2DH5	Нор	-3.15	20	Pass
State State of	TLVN	3DH5	Нор	-1.63	20	Pass
8DPSK	TNVN	3DH5	Нор	-1.35	20	Pass
	THVN	3DH5	Нор	-0.99	20	Pass

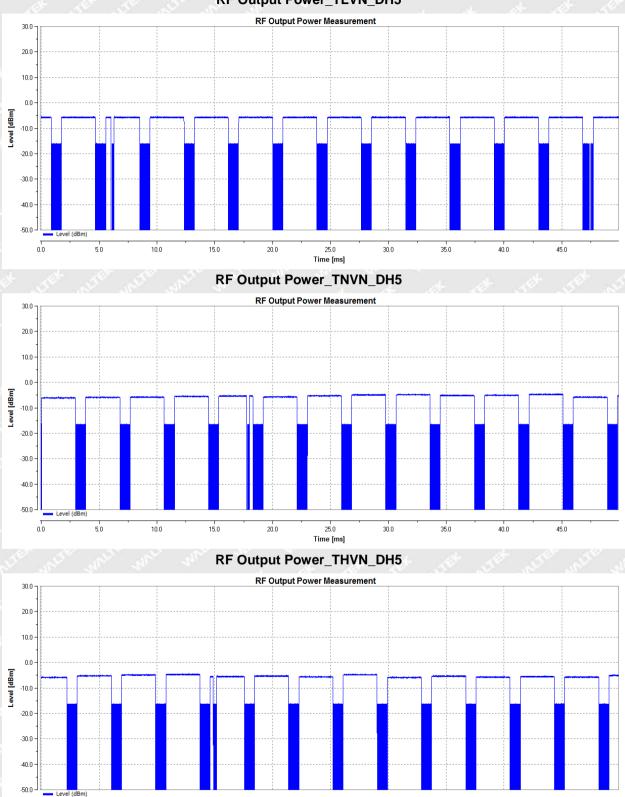
Remark: EIRP=Conducted power+ ANT gain

P



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25.0 Time [ms]

35.0

30.0

40.0

Test Graphs:

RF Output Power_TLVN_DH5

5.0

10.0

15.0

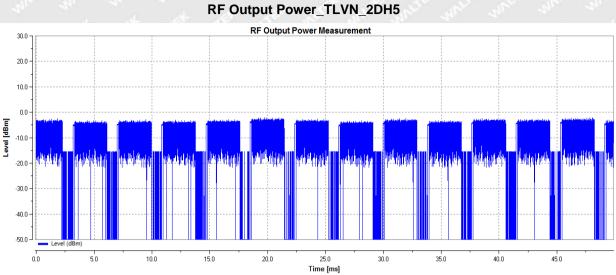
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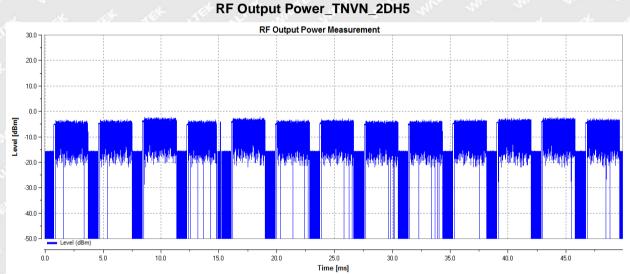
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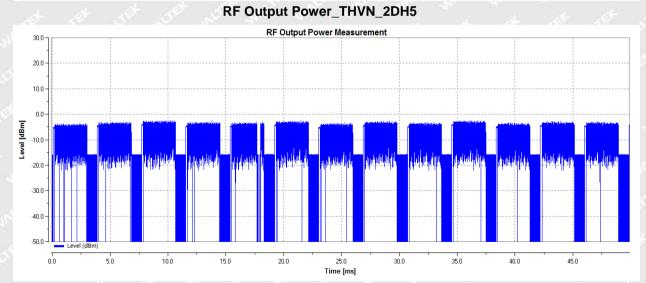
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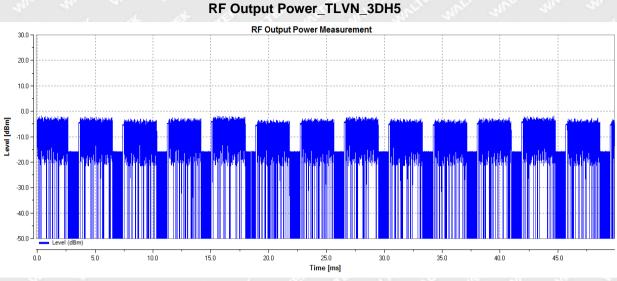


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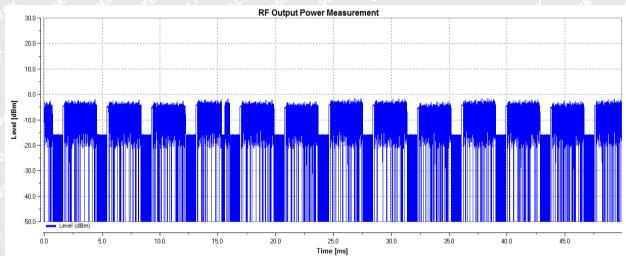
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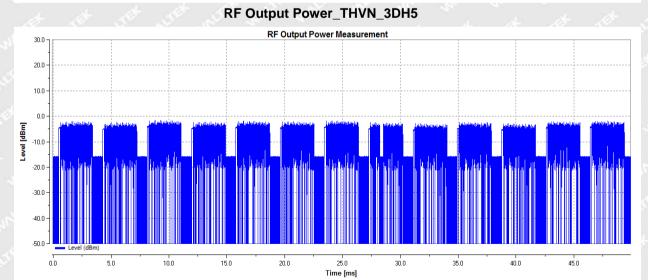


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RF Output Power_TNVN_3DH5





Remark: The antenna gain is not considered in the result plot.

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6.2 Accumulated Transmit Time, Minimum Frequency Occupation and Hopping Sequence

6.2.1 Standard Applicable

According to section 4.3.1.4.3, adaptive FHSS equipment shall be capable of operating over a minimum of 70 % of the band specified in table 1.

The Accumulated Transmit Time on any hopping frequency shall not be greater than 400 ms within any observation period of 400 ms multiplied by the minimum number of hopping frequencies (N) that have to be used.

In order for the FHSS equipment to comply with the Frequency Occupation requirement, it shall meet either of the following two options:

Option 1: Each hopping frequency of the Hopping Sequence shall be occupied at least once within a period not exceeding four times the product of the dwell time and the number of hopping frequencies in use.

Option 2: The occupation probability for each frequency shall be between $((1 / U) \times 25 \%)$ and 77 % where U is the number of hopping frequencies in use.

The Hopping Sequence(s) shall contain at least N hopping frequencies at all times, where N is either 15 or the result of 15 MHz divided by the minimum Hopping Frequency Separation in MHz, whichever is the greater.

For Adaptive FHSS equipment, from the N hopping frequencies defined above, the equipment shall consider at least one hopping frequency for its transmissions. Providing that there is no interference present on this hopping frequency with a level above the detection threshold defined in clause 4.3.1.7.2.2, point 5 or clause 4.3.1.7.3.2, point 5, then the equipment shall have transmissions on this hopping frequency. For Adaptive FHSS equipment using LBT, if a signal is detected during the CCA, the equipment may jump immediately to the next hopping frequency in the Hopping Sequence (see clause 4.3.1.7.2.2, point 2) provided the limit for Accumulated Transmit Time on the new hopping frequency is respected.

These measurements shall only be performed at normal test conditions.



6.2.2 Test Procedure

According to section 5.4.4.2.1 of the standard ETSI EN 300328, the test procedure shall be as follows:

Step 1:

- The output of the transmitter shall be connected to a spectrum analyser or equivalent.
- The analyser shall be set as follows:
 - Centre Frequency: Equal to the hopping frequency being investigated
 - Frequency Span: 0 Hz
 - RBW: ~ 50 % of the Occupied Channel Bandwidth
 - VBW: \geq RBW
 - Detector Mode: RMS
 - Sweep time: Equal to the applicable observation period (see clause 4.3.1.4.3.1 or

clause 4.3.1.4.3.2)

- Number of sweep points: 30 000
- Trace mode: Clear/Write
- Trigger: Free Run

Step 2:

• Save the trace data to a file for further analysis by a computing device using an appropriate software application or program.

Step 3:

• Identify the data points related to the frequency being investigated by applying a threshold.

The data points resulting from transmissions on the hopping frequency being investigated are assumed to have much higher levels compared to data points resulting from transmissions on adjacent hopping frequencies. If a clear determination between these transmissions is not possible, the RBW in step 1 shall be further reduced. In addition, a channel filter may be used.

• Count the number of data points identified as resulting from transmissions on the frequency being investigated and multiply this number by the time difference between two consecutive data points.

Step 4:

• The result in step 3 is the Accumulated Transmit Time which shall comply with the limit provided in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 and which shall be recorded in the test report.

Step 5:

This step is only applicable for equipment implementing Option 1 in clause 4.3.1.4.3.1 or Option 1 in clause 4.3.1.4.3.2 for complying with the Frequency Occupation requirement.

• Make the following changes on the analyser and repeat step 2 and step 3.

Sweep time: 4 × dwell time × Actual number of hopping frequencies in use.

The hopping frequencies occupied by the equipment without having transmissions during the dwell time

(blacklisted frequencies) should be taken into account in the actual number of hopping frequencies in use. If

this number cannot be determined (number of blacklisted frequencies unknown) it shall be assumed that the equipment uses the maximum possible number of hopping frequencies.

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• The result shall be compared to the limit for the Frequency Occupation defined in clause 4.3.1.4.3.1, Option 1 or clause 4.3.1.4.3.2, Option 1. The result of this comparison shall be recorded in the test report.

Step 6:

- Make the following changes on the analyser:
 - Start Frequency: 2 400 MHz
 - Stop Frequency: 2 483,5 MHz
 - RBW: ~ 50 % of the Occupied Channel Bandwidth (single hopping frequency)
 - VBW: \geq RBW
 - Detector Mode: Peak
 - Sweep time: 1 s; this setting may result in long measuring times. To avoid such long measuring times, an FFT analyser may be used
 - Number of sweep points: ~ 400 / Occupied Channel Bandwidth (MHz); the number of sweep points may need to be further increased in case of overlapping channels
 - Trace Mode: Max Hold
 - Trigger: Free Run
- Wait for the trace to stabilize. Identify the number of hopping frequencies used by the Hopping Sequence.

• The result shall be compared to the limit (value N) defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2. This value shall be recorded in the test report.

For equipment with blacklisted frequencies, it might not be possible to verify the number of hopping frequencies in use. However, they shall comply with the requirement for Accumulated Transmit Time and Frequency Occupation assuming the minimum number of hopping frequencies (N) defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 is used.

Step 7:

• For adaptive FHSS equipment, it shall be verified whether the equipment uses 70 % of the band specified in table 1. This verification can be done using the lowest and highest -20 dB points from the total spectrum

envelope obtained in step 6. The result shall be recorded in the test report.

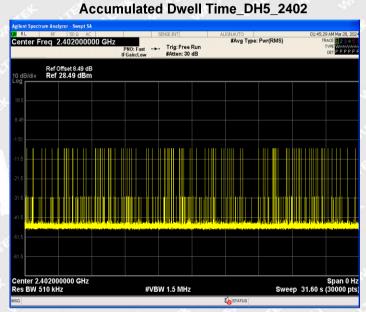


6.2.3 Test Result

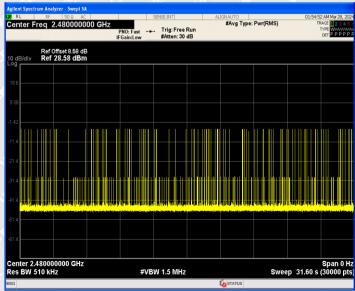
		Maximum	Accumulated Dwell Tim	e 2 3	
Modulation	Test Channel	Packet	Acc. Dwell Time (ms)	Limit (ms)	Verdict
OFOK	2402MHz	DH5	372.891	400	Pass
GFSK	2480MHz	DH5	392.905	400	Pass
	2402MHz	2DH5	377.105	400	Pass
π/4QPSK	2480MHz	2DH5	387.638	400	Pass
	2402MHz	3DH5	120.084	400	Pass
8DPSK	2480MHz	3DH5	396.065	400	Pass

Test Period: 400ms X Minimum number of hopping frequencis (N) Accumulated Dwell Time = Time slot length (Dwell time) X Number of data points within a test period

Test Graphs:



Accumulated Dwell Time_DH5_2480



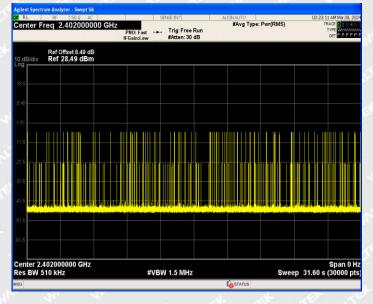
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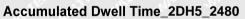
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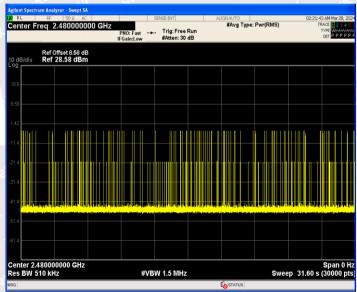
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Accumulated Dwell Time_2DH5_2402

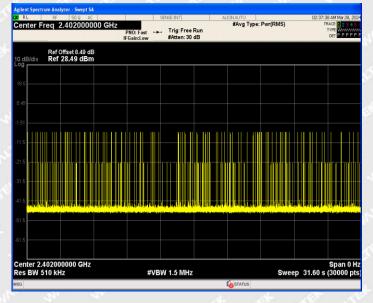




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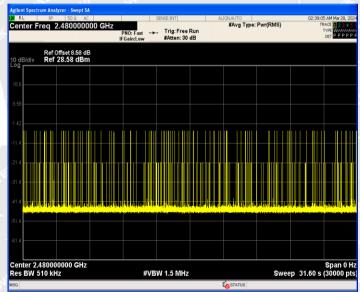


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Accumulated Dwell Time_3DH5_2402

Accumulated Dwell Time_3DH5_2480



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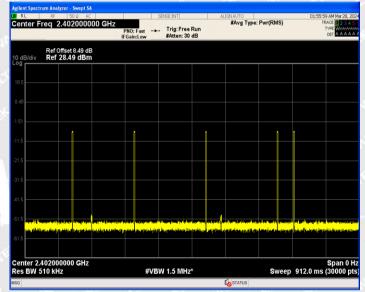


	Frequency Occupation requirement									
Modulation	Test Channel	Packet	Burst Number	Limit(Burst Number)	Verdict					
	2402MHz	DH5	5	≥1	Pass					
GFSK	2480MHz	DH5	4	≥1	Pass					
	2402MHz	2DH5	3	≥1	Pass					
π/4QPSK	2480MHz	2DH5	6 d-	≥1	Pass					
	2402MHz	3DH5	2	≥1	Pass					
8DPSK	2480MHz	3DH5	1.05	≥1	Pass					

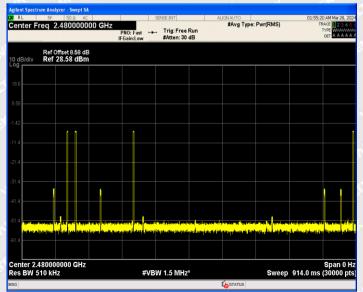
Occupation Time = Time slot length (Dwell time) X Number of data points within a test period

Test Graphs:

Minimum Frequency Occupation_DH5_2402

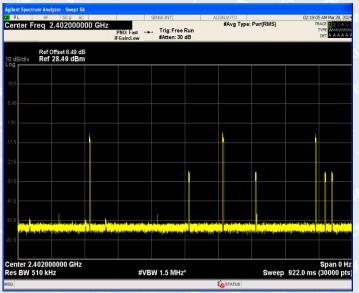


Minimum Frequency Occupation_DH5_2480



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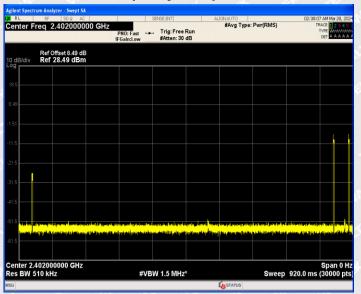
Minimum Frequency Occupation_2DH5_2402

Minimum Frequency Occupation_2DH5_2480

	1. Sec. 1. Sec				-				
Agilent Spectr	um Analyzer - Swept	SA							
RL	RF 50 g			SENSE:INT	AL	IGNAUTO		02:20:3	9 AM Mar 28, 2
enter F	reg 2.48000					#Avg Type:	Pwr(RMS)	TI	RACE 234
			PNO: Fast ↔	Trig: Free R					DET A A A
	_		IFGain:Low	#Atten: 30 d	B				DETATATA
0 dB/div	Ref Offset 8.58 Ref 28.58 dE	dB							
	Rei 20.30 uL		_						
8.6									
0.0									
.58									
.42									
-12									
1.4									
1.4									
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and a second	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	A STREET	in tennes i spint. In the	a a state a st	الالوقعاد ويبقع وبالد	A Robert Million	dist.index.mile	a Barrister	this ward
1.4									
	480000000 GH	Z							Span 0
les BW 5	10 kHz		#VE	3W 1.5 MHz*			Sweep	916.0 ms	(30000
SG						STATUS			
						v			

141 > 141





Minimum Frequency Occupation_3DH5_2402

Minimum Frequency Occupation_3DH5_2480

		yzer - Swept SJ									
e _{RL} Center	r Freq 2	50 9 AC 2.4800000	00 GHz	PNO: Fast IFGain:Low		Trig: Free #Atten: 30	Run	ALIGNAUTO #Avg	Type: Pwr(RMS)	TF	1 AM Mar 28, RACE 2 3 4 TYPE WHAT DET A A A A
0 dB/di	Ref C	offset 8.58 dE 28.58 dBm	3								
18.6											
.58											
.42											
1.4 —											
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	2.48000 V 510 kH	0000 GHz			#\/B\/	V 1.5 MHz	*		Swaan	926.0 ms	Span (
es Bv	V J I U KH	2			#YBY	V 1.3 IVIH2		STATUS		- 920.0 MIS	00000



	Hopping Sequence										
Modulation	Packet	Test Channel	Hop. (Num.)	Limit (Num.)	Band Use (%)	Limit (%)	Verdict				
GFSK	DH5	Нор	79	15	93.63	70	Pass				
π/4QPSK	2DH5	Нор	79	15	92.96	70	Pass				
8DPSK	3DH5	Нор	79	15	93.85	70	Pass				

Test Graphs:

Hopping Sequence_DH5

RL	RF	50 Q AC			SENSE: IN	IT		ALI	IGNAUTO		Pwr(RMS)		2 AM Mar 28 RACE
arker 2	2.40	011718223		PNO: Fast G		: Free R en: 30 d			Avg Ho				DET P P P
dB/div		Offset 8.49 df 20.00 dBm									Mkr	2 2.401 1 -24.	71 8 C 894 d
g	itter	Loide abii											
1.0													
			wwwww	······	· · · · · · ·	mm	<u>, , , , , , , , , , , , , , , , , , , </u>	Ś	www	\sim	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~		www
art 2.40			`									Stop 2.	
tes BW		Hz		#VE	3W 1.5	MHz					#SW	eep 1.00 s	(30000
			× 80 173 8 GHz	Y	dBm	FUNCT	ION	FUNCTI	ION WIDTH		FI	UNCTION VALUE	
			01 171 8 GHz	-24.894	dBm								
N 1 N 1	f			I(Δ) -0.0	12 dB								
Ν 1 Ν 1 Δ2 1	f		79.689 5 MHz										
N 1 N 1 A2 1	f		79.689 5 MHz										
Ν 1 Ν 1 Δ2 1	f		79.689 5 MHz										
	f		79.689 5 MHz										
	f		79.689 5 MHz										
Ν 1 Ν 1 Δ2 1			79.689 5 MHz						STATUS				

Hopping Sequence_2DH5

RL		D.Q. AC		SENSE:INT	ALIG	NAUTO		02:34:39 AM Mar 28, 2
arker 3	Δ 80.10	1436715 MHz	PNO: Fast G	Trig: Free I #Atten: 30		#Avg Type: Pw Avg Hold>100		TRACE 2 3 4 TYPE MWWWW DET P P P P
dB/div	Ref Offset Ref 20.0	8.49 dB 0 dBm					∆Mkr3	80.101 4 MH 0.096 d
1.0								. 1
		~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~						
2								34
1.0								
	0000 GHz							
	510 kHz		#VE	3W 1.5 MHz			#Sweep	top 2.48350 G 1.00 s (30000 p
R MODE T	RC SCL	×	Y	FUNC	TION FUNCTIO	N WIDTH	FUNCTION	I VALUE
1 N 1 2 N 1	f	2.480 151 5 G 2.400 957 5 G	Hz -24.98'					
3 Δ2 1 4	f (Δ)	80.101 4 M	Hz (Δ) 0.0	196 dB				
B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B B								



## Hopping Sequence_3DH5

RL		AC	5	ENSE:INT	ALIGN AUTO		03:18:03 AM Mar 28, 20
larker 3	Δ 80.1153	F	NO: Fast 🖵 Gain:Low	Trig: Free Ru #Atten: 30 dB		pe:Pwr(RMS) d>100/100	TRACE 234 TYPE M
0 dB/div	Ref Offset 8.4 Ref 20.00 (	49 dB dBm				ΔM	lkr3 80.115 4 MH 0.195 d
.og 10.0							
0.00							1
						~~~~~~	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
20.0 2							34:
30.0							
40.0							
<mark>-</mark>							
50.0 60.0							
70.0							
	0000 GHz 510 kHz		#VB	N 1.5 MHz		#Swe	Stop 2.48350 GH ep 1.00 s (30000 pt
MKR MODE T		×	Y	FUNCTIO	N FUNCTION WIDTH	FU	NCTION VALUE
1 N	f	2.479 870 4 GHz 2.400 943 6 GHz	-4.933 -24.927				
3 A2 1	f (Δ)	80.115 4 MHz		5 dB			
5							
6							
8							
9							

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6.3 Hopping Frequency Separation

6.3.1 Standard Applicable

For adaptive FHSS equipment, the minimum Hopping Frequency Separation shall be 100 kHz.

Adaptive FHSS equipment that switched to a non-adaptive mode for one or more hopping frequencies because interference was detected on each of these hopping frequencies with a level above the threshold level defined in clause 4.3.1.7.2.2, point 5 or clause 4.3.1.7.3.2, point 5, does not have to comply with the Hopping Frequency Separation provided in clause 4.3.1.5.3.1 for non-adaptive FHSS equipment. If the Hopping Frequency Separation is below the Occupied Channel Bandwidth but greater than 100 kHz, the equipment is allowed to continue to operate with this Hopping Frequency Separation as long as the interference remains present on these hopping frequencies. As this relaxed Hopping Frequency Separation only applies to adaptive FHSS equipment, the FHSS equipment shall continue to operate in an adaptive mode on all other hopping frequencies.

These measurements shall only be performed at normal test conditions.

6.3.2 Test Procedure

According to the section 5.4.5.2, the measurement procedure shall be as follows:

Step 1:

• The output of the transmitter shall be connected to a spectrum analyser or equivalent.

- The analyser shall be set as follows:
 - Centre Frequency: Centre of the two adjacent hopping frequencies
 - Frequency Span: Sufficient to see the complete power envelope of both hopping frequencies
 - RBW: 1 % of the span
 - VBW: 3 × RBW
 - Detector Mode: Max Peak
 - Trace Mode: Max Hold
 - Sweep Time: Auto

Step 2:

• Wait for the trace to stabilize.

• Use the marker-delta function to determine the Hopping Frequency Separation between the centres of the two adjacent hopping frequencies (e.g. by identifying peaks or notches at the centre of the power envelope for the two adjacent signals). This value shall be compared with the limits defined in clause 4.3.1.5.3 and shall be recorded in the test report.



6.3.3 Test Result

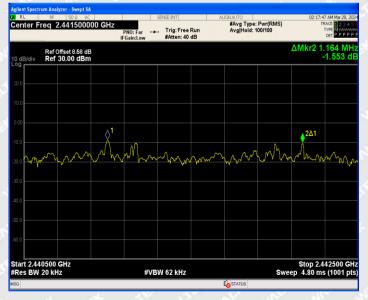
Modulation	Test Channel	Packet	Channel Separation (MHz)	Limit (MHz)	Verdict
GFSK	Нор	DH5	0.998	>=0.1	Pass
π/4QPSK	Нор	2DH5	1.164	>=0.1	Pass
8DPSK	Нор	3DH5	0.852	>=0.1	Pass

Test Graphs:

Hopping Frequency Separation_DH5



Hopping Frequency Separation_2DH5



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Hopping Frequency Separation_3DH5



6.4 Occupied Channel Bandwidth

6.4.1 Standard Applicable

The Occupied Channel Bandwidth for each hopping frequency shall be within the band given in table 1.

In addition, for non-adaptive FHSS equipment with e.i.r.p. greater than 10 dBm, the Occupied Channel Bandwidth for every occupied hopping frequency shall be equal to or less than 5 MHz.

6.4.2 Test Procedure

According to section 5.4.7.2, the measurement procedure shall be as follows:

Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

- · Centre Frequency: The centre frequency of the channel under test
- Resolution BW: ~ 1 % of the span without going below 1 %
- Video BW: 3 × RBW
- Frequency Span: 2 × Nominal Channel Bandwidth
- Detector Mode: RMS
- Trace Mode: Max Hold
- Sweep time: 1 s

Step 2:

Wait for the trace to stabilize.

Find the peak value of the trace and place the analyser marker on this peak.

Step 3:

Use the 99 % bandwidth function of the spectrum analyser to measure the Occupied Channel Bandwidth of the UUT. This value shall be recorded.

Make sure that the power envelope is sufficiently above the noise floor of the analyser to avoid the noise signals left and right from the power envelope being taken into account by this measurement.

Modulation	Channel	Packet	OCB (MHz)	FL (MHz)	FH (MHz)	Limit (MHz)	Verdict
OFOK	2402	DUE	0.88167	2401.56	2402.44	2400 to 2483.5	Pass
GFSK	2480	DH5	0.88782	2479.56	2480.45	2400 to 2483.5	Pass
	2402	ODUS	1.1976	2401.41	2402.60	2400 to 2483.5	Pass
π/4QPSK	2480	2DH5	1.1995	2479.41	2480.61	2400 to 2483.5	Pass
	2402	aDUIC	1.2052	2401.40	2402.60	2400 to 2483.5	Pass
8DPSK	2480	3DH5	1.2049	2479.40	2480.60	2400 to 2483.5	Pass

6.4.3 Test Result



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Test Graphs:



Occupied Channel Bandwidth_DH5_2402

Occupied Channel Bandwidth_DH5_2480



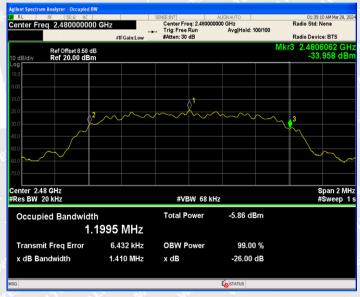
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Occupied Channel Bandwidth_2DH5_2402

Occupied Channel Bandwidth_2DH5_2480



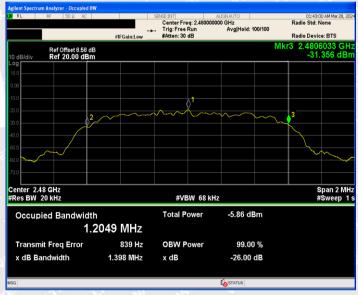
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Occupied Channel Bandwidth_3DH5_2402

Occupied Channel Bandwidth_3DH5_2480



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6.5 Transmitter unwanted emissions in the out-of-band domain

6.5.1 Standard Applicable

According to section 4.3.1.9.3, The transmitter unwanted emissions in the out-of-band domain but outside the allocated band, shall not exceed the values provided by the mask in figure below

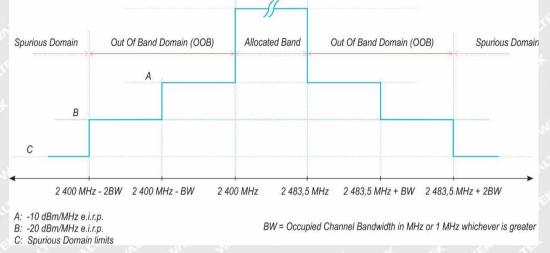


Figure 1: Transmit mask

Within the 2 400 MHz to 2 483,5 MHz band, the Out-of-band emissions are fulfilled by compliance with the Occupied Channel Bandwidth requirement

6.5.2 Test Procedure

According to the section 5.3.9.2.1, the measurement procedure shall be as follows:

The Out-of-band emissions within the different horizontal segments of the mask provided in figures 1 and 3 shall

be measured using the steps below. This method assumes the spectrum analyser is equipped with the Time Domain Power option.

Step 1:

- Connect the UUT to the spectrum analyser and use the following settings:
 - Centre Frequency: 2 484 MHz
 - Span: 0 Hz
 - Resolution BW: 1 MHz
 - Filter mode: Channel filter
 - Video BW: 3 MHz
 - Detector Mode: RMS
 - Trace Mode: Max Hold
 - Sweep Mode: Continuous
 - Sweep Points: Sweep Time [s] / (1 μ s) or 5 000 whichever is greater
 - Trigger Mode: Video trigger

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NOTE 1: In case video triggering is not possible, an external trigger source may be used.

- Sweep Time: > 120 % of the duration of the longest burst detected during the measurement of the

RF Output Power

Step 2: (segment 2 483,5 MHz to 2 483,5 MHz + BW)

• Adjust the trigger level to select the transmissions with the highest power level.

• For frequency hopping equipment operating in a normal hopping mode, the different hops will result in signal bursts with different power levels. In this case the burst with the highest power level shall be selected.

• Set a window (start and stop lines) to match with the start and end of the burst and in which the RMS power

shall be measured using the Time Domain Power function.

· Select RMS power to be measured within the selected window and note the result which is the RMS power

within this 1 MHz segment (2 483,5 MHz to 2 484,5 MHz). Compare this value with the applicable limit

provided by the mask.

• Increase the centre frequency in steps of 1 MHz and repeat this measurement for every 1 MHz segment within the range 2 483,5 MHz to 2 483,5 MHz + BW. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + BW - 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 3: (segment 2 483,5 MHz + BW to 2 483,5 MHz + 2BW)

• Change the centre frequency of the analyser to 2 484 MHz + BW and perform the measurement for the first 1 MHz segment within range 2 483,5 MHz + BW to 2 483,5 MHz + 2BW. Increase the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + 2 BW - 0,5 MHz.

Step 4: (segment 2 400 MHz - BW to 2 400 MHz)

• Change the centre frequency of the analyser to 2 399,5 MHz and perform the measurement for the first 1 MHz segment within range 2 400 MHz - BW to 2 400 MHz Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - 2BW + 0,5 MHz.

Step 5: (segment 2 400 MHz - 2BW to 2 400 MHz - BW)

• Change the centre frequency of the analyser to 2 399,5 MHz - BW and perform the measurement for the first 1 MHz segment within range 2 400 MHz - 2BW to 2 400 MHz - BW. Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - 2BW + 0,5 MHz.

Step 6:

• In case of conducted measurements on equipment with a single transmit chain, the declared antenna assembly gain "G" in dBi shall be added to the results for each of the 1 MHz segments and compared with the limits provided by the mask given in figure 1 or figure 3. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered.

• In case of conducted measurements on smart antenna systems (equipment with multiple transmit chains), the measurements need to be repeated for each of the active transmit chains. The declared antenna assembly gain "G" in dBi for a single antenna shall be added to these results. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered.

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Comparison with the applicable limits shall be done using any of the options given below:

- Option 1: the results for each of the transmit chains for the corresponding 1 MHz segments shall be added. The additional beamforming gain "Y" in dB shall be added as well and the resulting values compared with the limits provided by the mask given in figure 1 or figure 3.

- Option 2: the limits provided by the mask given in figure 1 or figure 3 shall be reduced by $10 \times \log_{10}(Ach)$ and the additional beamforming gain Y in dB. The results for each of the transmit chains shall be individually compared with these reduced limits.

NOTE 2: A ch refers to the number of active transmit chains.

It shall be recorded whether the equipment complies with the mask provided in figure 1 or figure 3. RBW=1MHz VBW=3MHz

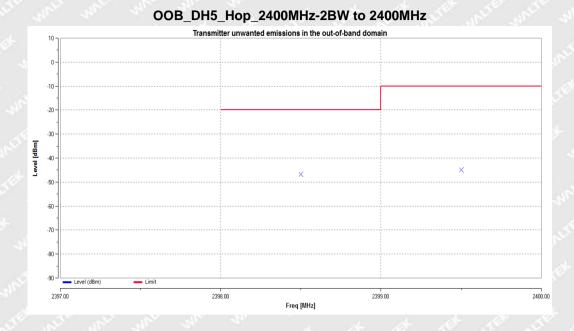
Test Mode	Test Channel	Packet	Test Segment (MHz)	Max. Emissions Reading (dBm)	Limit (dBm)	Verdict
GFSK	Нор	DH5	2400-2BW to 2400-BW	-46.86	<=-20	Pass
			2400-BW to 2400	-44.87	<=-10	Pass
			2483.5 to 2483.5+BW	-45.78	<=-10	Pass
			2483.5+BW to 2483.5+2BW	-45.67	<=-20	Pass
π/4QPSK	Нор	2DH5	2400-2BW to 2400-BW	-46.75	<=-20	Pass
			2400-BW to 2400	-44.16	<=-10	Pass
			2483.5 to 2483.5+BW	-46.38	<=-10	Pass
			2483.5+BW to 2483.5+2BW	-46.10	<=-20	Pass
8DPSK	Нор	3DH5	2400-2BW to 2400-BW	-46.78	<=-20	Pass
			2400-BW to 2400	-41.57	<=-10	Pass
			2483.5 to 2483.5+BW	-45.48	<=-10	Pass
			2483.5+BW to 2483.5+2BW	-45.35	<=-20	Pass

6.5.3 Test Result

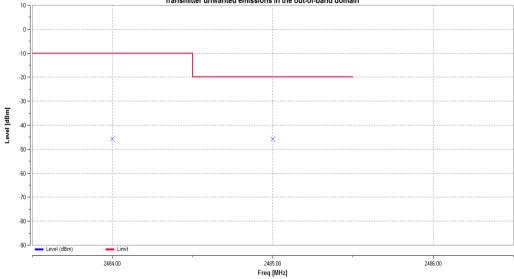


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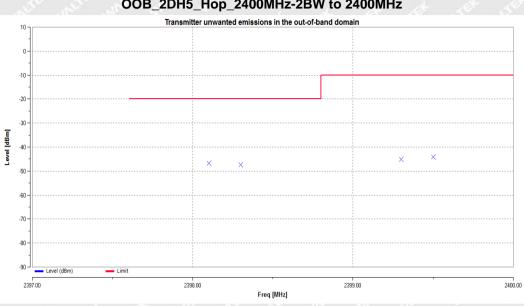
Test Graphs:



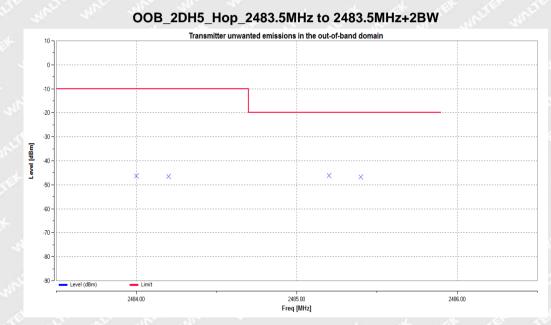
OOB_DH5_Hop_2483.5MHz to 2483.5MHz+2BW Transmitter unwanted emissions in the out-of-band domain







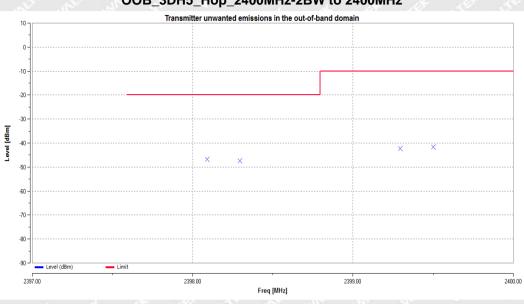
OOB_2DH5_Hop_2400MHz-2BW to 2400MHz



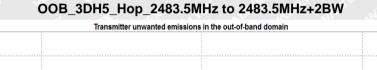
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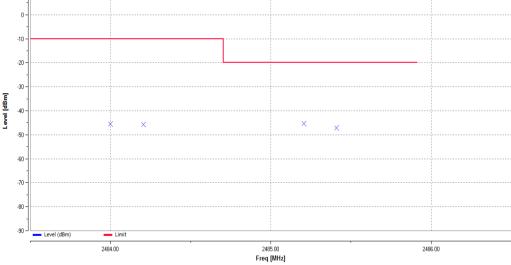
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OOB_3DH5_Hop_2400MHz-2BW to 2400MHz





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6.6 Transmitter unwanted emissions in the spurious domain

6.6.1 Standard Applicable

According to section 4.3.1.10.3

The transmitter unwanted emissions in the spurious domain shall not exceed the values given in the following table.

Frequency Range	Maximum Power	Bandwidth	
30 MHz to 47 MHz	-36 dBm	100 kHz	
47 MHz to 74 MHz	-54 dBm	100 kHz	
74 MHz to 87,5 MHz	-36 dBm	100 kHz	
87,5 MHz to 118 MHz	-54 dBm	100 kHz	
118 MHz to 174 MHz	-36 dBm	100 kHz	
174 MHz to 230 MHz	-54 dBm	100 kHz	
230 MHz to 470 MHz	-36 dBm	100 kHz	
470 MHz to 694 MHz	-54 dBm	100 kHz	
694 MHz to 1 GHz	-36 dBm	100 kHz	
1 GHz to 12,75 GHz	-30 dBm	1 MHz	

6.6.2 Test Procedure

The device under test has an integral antenna and the radiated measurement shall apply to the device, using the method of measurement as described in the ETSI EN 300 328 section 5.4.9.2.

RBW=100kHz VBW=300kHz 30MHz-1GHz RBW=1MHz VBW=3MHz 1GHz-12.75GHz 5



6.6.3 Test Result

Note: All test modes (different data rate and different modulation) are performed, but only the worst case is recorded in this report.

	Receiver	Turn	RX An	tenna	S	Substitute	ed 🖉 🤞	Absolute		1997 - 19
Frequency (MHz)	Reading (dBµV)	table Angle (°)	Height (m)	Polar (H/V)	SG Level (dBm)	Cable (dB)	Antenna Gain (dB)	Level (dBm)	Limit (dBm)	Margin (dB)
A A	de .	đ.	5 2	TX_DH	5_Low Cl	nannel	An.	3. S.	4	+ .4
728.13	25.85	163	1.5	H	-73.35	0.20	0.00	-73.15	-36	-37.15
728.13	24.90	186	1.9	V	-73.66	0.20	0.00	-73.46	-36	-37.46
1104.73	49.32	250	1.7	Н	-49.66	0.25	6.00	-55.41	-30	-25.41
1104.73	49.73	204	1.4	V	-50.97	0.25	6.00	-56.72	-30	-26.72
1639.80	45.61	312	1.7	Н	-49.99	0.30	9.40	-59.09	-30	-29.09
1639.80	45.70	143	1.4	≶″V	-49.63	0.30	9.40	-58.73	-30	-28.73
in aller	m. n			TX_DH	5_High C	hannel	5	mark with	-Mar	"alle
186.74	38.31	128	1.0	્રમુ	-71.70	0.15	0.00	-71.55	-54	-17.55
186.74	32.81	225	1.0	V	-74.81	0.15	0.00	-74.66	-54	-20.66
3266.06	42.11	258	1.1	H	-49.34	2.11	12.00	-59.23	-30	-29.23
3266.06	43.75	276	1.5	V	-45.87	2.11	12.00	-55.76	-30	-25.76
4446.57	44.57	172	1.3	S H	-46.62	2.57	12.70	-56.75	-30	-26.75
4446.57	44.21	142	1.5	V	-44.94	2.57	12.70	-55.07	-30	-25.07



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6.7 Receiver spurious emissions

6.7.1 Standard Applicable

According to section 4.3.1.11.3, The spurious emissions of the receiver shall not exceed the values given in table below

NOTE: In case of equipment with antenna connectors, these limits apply to emissions at the antenna port (conducted) and to the emissions radiated by the cabinet. In case of integral antenna equipment (without temporary antenna connectors), these limits apply to emissions radiated by the equipment. Spurious emission limits for receivers

Frequency Range	Maximum Power	Bandwidth
30 MHz to 1 GHz	-57 dBm	100 kHz
1 GHz to 12,75 GHz	-47 dBm	1 MHz

6.7.2 Test Procedure

The device under test has an integral antenna and the radiated measurement shall apply to the device, using the method of measurement as described in the ETSI EN 300 328 section 5.4.10.2.

RBW=100kHz	VBW=300kHz	30MHz-1GHz
RBW=1MHz	VBW=3MHz	1GHz-12.75GHz

6.7.3 Test Result

Note: All test modes (different data rate and different modulation) are performed, but only the worst case is recorded in this report.

	Receiver	Turn	RX An	tenna	0° 50	Substitute	d	Absolute	- suc.	-20
Frequency (MHz)	ency Reading	table Angle (°)	Height (m)	Polar (H/V)	SG Level (dBm)	Cable (dB)	Antenna Gain (dB)	Level (dBm)	Limit (dBm)	Margin (dB)
5° . 5	er our	Nº ST	sur.	RX_DH	5_Low C	hannel	A 18	1 J.	5	55
44.29	35.74	285	1.1	.⊴H⁻	-73.22	0.15	0.00	-73.07	-57	-16.07
44.29	37.08	133	1.3	V	-71.24	0.15	0.00	-71.09	-57	-14.09
3052.67	42.33	122	1.2	∲ Н	-50.08	2.08	11.50	-59.50	-47	-12.50
3052.67	39.50	152	1.4	V	-50.45	2.08	11.50	-59.87	-47	-12.87
4013.36	43.58	105	1.7	H	-47.69	2.49	12.60	-57.80	-47	-10.80
4013.36	40.47	208	1.4	V	-49.44	2.49	12.60	-59.55	-47	-12.55
	to the	di te	d.	RX_DH	5_High C	hannel	r. m.	-34	20	
131.97	35.81	242	2.0	Н	-72.19	0.15	0.00	-72.04	-57	-15.04
131.97	32.45	312	1.8	V	-74.50	0.15	0.00	-74.35	-57	-17.35
2544.65	47.90	314	1.8	Н	-45.76	0.43	10.60	-55.93	-47	-8.93
2544.65	42.17	287	1.8	V	-47.77	0.43	10.60	-57.94	-47	-10.94
4836.01	41.40	145	1.2	Н	-49.77	2.64	12.70	-59.83	-47	-12.83
4836.01	40.13	201	1.5	V	-48.11	2.64	12.70	-58.17	-47	-11.17

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6.8 Receiver Blocking

6.8.1 Standard Applicable

According to section 4.3.1.12.3, Receiver blocking is a measure of the ability of the equipment to receive a wanted signal on its operating channel without exceeding a given degradation in the presence of an unwanted signal (blocking signal) at frequencies other than those of the operating band.

Load Based Equipment not using any of the mechanisms referenced above shall comply with the following minimum set of requirements :

The minimum performance criterion shall be a PER less than or equal to 10 %. The manufacturer may declare alternative performance criteria as long as that is appropriate for the intended use of the equipment (see clause 5.4.1.t)).

While maintaining the minimum performance criteria as defined in clause 4.3.1.12.3, the blocking levels at specified frequency offsets shall be equal to or greater than the limits defined for the applicable receiver category 1, 2 and 3 provided in table 14, table 15 or table 16.

Receiver category 1

Adaptive equipment with a maximum RF output power greater than 10 dBm e.i.r.p. shall be considered as receiver category 1 equipment.

Wanted signal mean power from companion device (dBm) (see notes 1 and 4)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 4)	Type of blocking signal	
(-133 dBm + 10 × log ₁₀ (OCBW)) or -68 dBm whichever is less (see note 2)	2 380 2 504		a survey with	
(-139 dBm + 10 × log ₁₀ (OCBW)) or -74 dBm whichever is less (see note 3)	2 300 2 330 2 360 2 524 2 584 2 674	-34	cw	

 Table 6: Receiver Blocking parameters for Receiver Category 1 equipment

NOTE 1: OCBW is in Hz.

- NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to Pmin + 26 dB where Pmin is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.
- NOTE 3: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to Pmin + 20 dB where Pmin is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.
- NOTE 4: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

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Receiver category 2

Non-adaptive equipment with a Medium Utilization (MU) factor greater than 1 % and less than or equal to 10 % or adaptive equipment with a maximum RF output power of 10 dBm e.i.r.p. shall be considered as receiver category 2 equipment.

Wanted signal mean power from companion device (dBm) (see notes 1 and 3)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 3)	Type of blocking signal
$(-139 \text{ dBm} + 10 \times \log_{10}(\text{OCBW}) + 10 \text{ dB})$ or $(-74 \text{ dBm} + 10 \text{ dB})$ whichever is less (see note 2)	2 380 2 504 2 300 2 584	-34	CW

Table 7: Receiver Blocking parameters for Receiver Category 2 equipment

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to Pmin + 26 dB where Pmin is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

Receiver category 3

Non-adaptive equipment with a maximum Medium Utilization (MU) factor of 1 % or adaptive equipment with a maximum RF output power of 0 dBm e.i.r.p. shall be considered as receiver category 3 equipment.

Wanted signal mean power from companion device (dBm) (see notes 1 and 3)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 3)	Type of blocking signal
$(-139 \text{ dBm} + 10 \times \log_{10}(\text{OCBW}) + 20 \text{ dB})$ or (-74 dBm + 20 dB) whichever is less (see note 2)	2 380 2 504 2 300 2 584	-34	cw

Table 8: Receiver Blocking parameters for Receiver Category 3 equipment

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative the test may be performed using a wanted signal up to Pmin + 30 dB where Pmin is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.



6.8.2 Test Procedure

Step 1:

• For non-frequency hopping equipment, the UUT shall be set to the lowest operating channel.

Step 2:

• The blocking signal generator is set to the first frequency as defined in the appropriate table corresponding to the receiver category and type of equipment.

Step 3:

• With the blocking signal generator switched off, a communication link is established between the UUT and the associated companion device using the test setup shown in figure 6. The variable attenuator is set to a value that achieves the minimum performance criteria as specified in clause 4.3.1.12.3 or clause 4.3.2.11.3 with a resolution of at least 1 dB. The resulting level for the wanted signal at the input of the UUT is Pmin. This value shall be measured and recorded in the test report.

• The signal level is increased by the value provided in the table corresponding to the receiver category and type of equipment.

Step 4:

• The blocking signal at the UUT is set to the level provided in the table corresponding to the receiver category and type of equipment. It shall be verified and recorded in the test report that the performance criteria as specified in clause 4.3.1.12.3 or clause 4.3.2.11.3 is met.

Step 5:

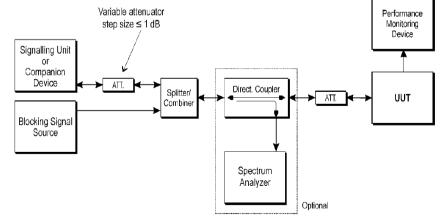
• Repeat step 4 for each remaining combination of frequency and level for the blocking signal as provided in the table corresponding to the receiver category and type of equipment.

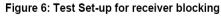
Step 6:

• For non-frequency hopping equipment, repeat step 2 to step 5 with the UUT operating at the highest operating channel.

6.8.3 Test Setup

According to the section 5.4.11.2.1, the test block diagram shall be used.





All test procedure is carried to the section 5.4.11.2.1 RBW/VBW=8MHz/30MHz

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6.8.4 Test Result

		GFSK	_DH5			
	R	eceiver Blocki	ng Categories 2	"num	the su	
Wanted signal meanpower from companion device (dBm)	OCBW (Hz)	Blocking signal frequency (MHz)	Blocking signal power(dBm) CW	PER (%)	Limit	Results
	* #	2380	-34	4.5	_ - ≤10%	Pass
CO 55	004070	2504	-34	3.7		
-69.55	881670	2300	-34	0.6		
	where where	2584	-34	4.9	15 3	

NOTE 1: For equipment that supports a PER or FER test to be performed, the minimum performance criterion shall be a PER or FER less than or equal to 10 %.

NOTE 2: For equipment that does not support a PER or a FER test to be performed, the minimum performance criterion shall be no loss of the wireless transmission function needed for the intended use of the equipment.

NOTE 3: The smallest channel bandwidth and the lowest data rate for this channel bandwidth which still allows the equipment to operate as intended shall be used. This mode of operation shall be aligned with the performance criteria defined in clause 4.3.1.12.3 or clause 4.3.2.11.3 and shall be described in the test report.

π/4QPSK_2DH5						
	R	eceiver Blocki	ng Categories 2	n a		
Wanted signal meanpower from companion device (dBm)	OCBW (Hz)	Blocking signal frequency (MHz)	Blocking signal power(dBm) CW	PER (%)	Limit	Results
	de la	2380	-34	3.9		Pass
CO 00	1407000	2504	-34	2.8		
-68.22 1197600	1197600	1197600 2300	-34	3.8	- ≤10%	
	no m	2584	-34	3.4	5 5	

NOTE 1: For equipment that supports a PER or FER test to be performed, the minimum performance criterion shall be a PER or FER less than or equal to 10 %.

NOTE 2: For equipment that does not support a PER or a FER test to be performed, the minimum performance criterion shall be no loss of the wireless transmission function needed for the intended use of the equipment.

NOTE 3: The smallest channel bandwidth and the lowest data rate for this channel bandwidth which still allows the equipment to operate as intended shall be used. This mode of operation shall be aligned with the performance criteria defined in clause 4.3.1.12.3 or clause 4.3.2.11.3 and shall be described in the test report.



		8DPSK	_3DH5			
Set Set at	R	eceiver Blockir	ng Categories 2	e de	đ.	5 5
Wanted signal meanpower from companion device (dBm)	OCBW (Hz)	Blocking signal frequency (MHz)	Blocking signal power(dBm) CW	PER (%)	Limit	Results
	aller white	2380	-34	4.2	_ - ≤10%	Pass
C0 40	4004000	2504	-34	5.9		
-68.19 12049	1204900	2300	-34	2.7		
		2584	-34	5.0	and a	er m

NOTE 1: For equipment that supports a PER or FER test to be performed, the minimum performance criterion shall be a PER or FER less than or equal to 10 %.

NOTE 2: For equipment that does not support a PER or a FER test to be performed, the minimum performance criterion shall be no loss of the wireless transmission function needed for the intended use of the equipment.

NOTE 3: The smallest channel bandwidth and the lowest data rate for this channel bandwidth which still allows the equipment to operate as intended shall be used. This mode of operation shall be aligned with the performance criteria defined in clause 4.3.1.12.3 or clause 4.3.2.11.3 and shall be described in the test report.

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7 Photographs – Test Setup

7.1 Photograph – Spurious Emissions Test Setup





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8 Photographs – EUT Constructional Details

Please refer to "ANNEX".

=====End of Report======

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TEST REPORT

Reference No.	:	WTF24F03057624W002
Applicant	. in C	Mid Ocean Brands B.V.
Address	NITE	7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong
Manufacturer	d.	114746
Address	: <	and when the left the state with and and and
Product Name	÷: _	Wireless bamboo speaker
Model No	-m	MO6385
Test specification	NALI	EN 62479:2010 EN 50663:2017
Date of Receipt sample	Gest-	2024-03-21
Date of Test	ż	2024-03-23
Date of Issue	: 5	2024-04-08
Test Report Form No	:	WEW-62479A-01B
Test Result	:	Pass A A A A A A A A A A A A A A A A A A

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

Prepared By: Waltek Testing Group (Foshan) Co., Ltd. Address: 1/F., Building 19, Sunlink Machinery City, Xingye 4 Road, Guanglong Industrial Park, Chihua Neighborhood Committee, Chencun Town, Shunde District, Foshan, Guangdong, China

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Tested by:

NHong

Roy Hong

Approved by:

VOU Z

Danny Zhou

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1 Test Summary

Test	Test Method	Class / Severity	Result
RF Exposure	EN 62479:2010 EN 50663:2017	white white white	Pass

Pass Test item meets the requirement

N/A Not Applicable

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2 Contents

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3 General Information

3.1 General Description of E.U.T.

Product Name :	Wireless bamboo speaker
Model No	MO6385
Remark :	- WALL WALL WALL WALL
Rated Voltage:	Input: DC 5V, 0.3A Battery: 3.7V, 300mAh, 1.11Wh
Battery Capacity :	
Adapter Model	march and a show a

3.2 Technical Specification

Bluetooth Version :	Bluetooth V5.3 (BR+EDR)
Frequency Range :	2402-2480MHz
Maximum RF Output Power :	-0.99 dBm (EIRP)
Type of Modulation	GFSK, π/4QPSK, 8DPSK
Data Rate :	1Mbps, 2Mbps, 3Mbps
Quantity of Channels	79
Channel Separation	1MHz
Antenna installation	PCB Antenna
Antenna Gain :	1dBi

3.3 Standards Applicable for Testing

The tests were performed according to following standards:

 EN 62479:2010
 Assessment of electronic and electrical equipment related to human exposure restrictions for electromagnetic fields (0 Hz - 300 GHz)

 EN 52222 2217
 Output to the block of the second second

EN 50663:2017 Generic standard for assessment of low power electronic and electrical equipment related to human exposure restrictions for electromagnetic fields (10 MHz - 300 GHz)

3.4 Disclaimer

The antenna gain information is provided by the customer. The laboratory is not responsible for the accuracy of the antenna gain information.

RF EXPOSURE BASIC RESTRICTIONS 4

4.1 Limits Standard Applicable

According to EN 62479:2010, Assessment of the compliance of low power electronic and electrical equipment with the basic restrictions related to human exposure to electromagnetic fields (10 MHz to 300 GHz).

Low-power exclusion level Pmax based on considerations of SAR

When SAR is the basic restriction, a conservative minimum value for Pmax can be derived, equal to the localized SAR limit (SARmax) multiplied by the averaging mass (m):

$$P_{\max} = SAR_{\max} m \tag{A.1}$$

Example values of P_{max} according to Equation (A.1) are provided in Table A.1 for cases described by the ICNIRP guidelines [1], IEEE Std C95.1-1999 [2] and IEEE Std C95.1-2005 [3] where SAR limits are defined. Other exposure guidelines or standards may be applicable depending on national regulations.

Table A.1 – Example values of SAR-based P _{max} for some cases described by ICNIRP,
IEEE Std C95.1-1999 and IEEE Std C95.1-2005

Guideline / Standard	SAR limit, SAR _{max}	Averaging mass, m	P _{max}	Exposure tier ^a	Region of body ^a
	W/kg	g	mW		
	2	10	20	General public	Head and trunk
ICNIRP [1]	4	10	40	General public	Limbs
	10	10	100	Occupational	Head and trunk
	20	10	200	Occupational	Limbs
IEEE Std C95.1-1999 [2]	1,6	1	1,6	Uncontrolled environment	Head, trunk, arms, legs
	4	10	40	Uncontrolled environment	Hands, wrists, feet and ankles
	8	1	8	Controlled environment	Head, trunk, arms, legs
	20	10	200	Controlled environment	Hands, wrists, feet and ankles
	2	10	20	Action level	Body except extremities and pinnae
IEEE Std C95.1-2005 [3]	4	10	40	Action level	Extremities and pinnae
	10	10	100	Controlled environment	Body except extremities and pinnae
	20	10	200	Controlled environment	Extremities and pinnae



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4.2 Evaluation Methods

Based on the above standard limit, the basic restriction at frequency between 10MHz to 300GHz is on localized SAR in the head. Any device with output power below 20mW cannot produce an exposure exceeding this restriction under the most pessimistic exposure conditions.

The basic restriction is 2W/Kg for general public device, so any unit which supplies less than 20mW from it's antenna port, averaged over 6 minutes, will meet the basic restriction.

4.3 Evaluation Results

Maximum Average Output Power

Frequency	RF Output Power	RF Output Power	Limit	Result
(MHz)	(dBm)	(mW)	(mW)	
2402-2480	-0.99	0.796	20	Pass

Remark: The details of RF output power refer to report No.WTF24F03057624W001.

Since average output power at worse case is: 0.796 mW which cannot exceed the exempt condition, 20mW specified in EN 62479. It is deemed to full fit the requirement of RF exposure basic restriction specified in EC Council Recommendation (1999/519/EC).

5 Photographs – EUT Constructional Details

Please refer to "ANNEX".

=====End of Report======



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